

which is required for various user experiments. The lower which provide the transient voltage signal to subsequent



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Bunch Arrival-Time Measurement with Rod-Shaped Pickups on a Printed Circuit Board for X-Ray Free-Electron Lasers

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Close to the bunch Large effective area Integrated combination

Strong ringing the CST model. Transition diffraction radiation

@ $Q_{\rm B} = 20 \, {\rm pC}, \, \sigma_{\rm B} = 1 \, {\rm mm}$ 0.20.4

Cross-section of

Simulated output voltage after the feedthrough (v-type).

SUMMARY AND OUTLOOK

80 % of the project goal using rod-shaped pickups Simulations validated by S-parameter measurements **114 %** with integrated PCB combination network

- Foreseen measurements: Build an hermetic demonstrator Use pulse generator or e.g. ARES
 - Build PCB combination network

Further simulations:

- Wakefield treatment
- Optimization of pickup
- geometry and combination network

REFERENCES AND FURTHER READINGS

[1] A. Angelovski et al., "Pickup signal improvement for high bandwidth BAMs for FLASH and European - XFEL", IBIC'13, Oxford, Sep. 2013, paper WEPC40, pp. 778-781. [2] F. Löhl et al., "Electron bunch timing with femtosecond precision in a superconducting free-electron laser", Phys. Rev. Lett., Vol. 104, No. 14, 2010. doi:/10.1103/PhysRevLett.104.144801